



#### P-CHANNEL ENHANCEMENT MODE MOSFET

## **Product Summary**

BV <sub>DSS</sub>	R <sub>DS(ON)</sub> Max	I <sub>D</sub> Max T <sub>C</sub> = +25°C
	105mΩ @ V <sub>GS</sub> = -10V	-7.3A
-60V	130mΩ @ V <sub>GS</sub> = -4.5V	-6.5A

## **Description and Applications**

This MOSFET is designed to meet the stringent requirements of automotive applications. It is qualified to AEC-Q101, supported by a PPAP and is ideal for use in:

- Backlighting
- Power Management Functions
- DC-DC Converters

# **Features and Benefits**

- Low On-Resistance
- Low Input Capacitance
- Fast Switching Speed
- Totally Lead-Free & Fully RoHS Compliant (Notes 1 & 2)
- Halogen and Antimony Free. "Green" Device (Note 3)
- Qualified to AEC-Q101 Standards for High Reliability
- PPAP Capable (Note 4)

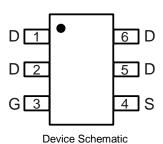
## **Mechanical Data**

- Case: TSOT26
- Case Material: Molded Plastic, "Green" Molding Compound.
  UL Flammability Classification Rating 94V-0
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminal Connections Indicator: See Diagram
- Terminals: Finish Matte Tin Annealed over Copper Leadframe.
  Solderable per MIL-STD-202, Method 208 63
- Weight: 0.008 grams (Approximate)

#### TSOT26









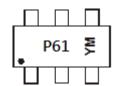
# G S Equivalent Circuit

## **Ordering Information (Note 5)**

Part Number	Case	Packaging
DMP6110SVTQ-7	TSOT26	3,000/Tape & Reel
DMP6110SVTQ-13	TSOT26	10,000/Tape & Reel

- Notes: 1. No purposely added lead. Fully EU Directive 2002/95/EC (RoHS), 2011/65/EU (RoHS 2) & 2015/863/EU (RoHS 3) compliant.
  - 2. See https://www.diodes.com/quality/lead-free/ for more information about Diodes Incorporated's definitions of Halogen- and Antimony-free, "Green" and Lead-free.
  - 3. Halogen- and Antimony-free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + Cl) and <1000ppm antimony compounds.
  - 4. Automotive products are AEC-Q101 qualified and are PPAP capable. Refer to https://www.diodes.com/quality/.
  - 5. For packaging details, go to our website at https://www.diodes.com/design/support/packaging/diodes-packaging/

## **Marking Information**



P61 = Product Type Marking Code YM or  $\overline{Y}M$  = Date Code Marking Y = Year (ex: F = 2018) M = Month (ex: 9 = September)

### Date Code Key

Year	2016	2017	2018	2019	2020	2021	2022	2023	2024
Code	D	E	F	G	Н	I	J	K	L
	•	•	•	•	•	•		•	

Month	Jan	Feb	Mar	Apr	May	Jun	Jul	Aug	Sep	Oct	Nov	Dec
Code	1	2	3	4	5	6	7	8	9	0	N	D



# **Maximum Ratings** ( $@T_A = +25^{\circ}C$ , unless otherwise specified.)

Characteristic	Symbol	Value	Unit	
Drain-Source Voltage		$V_{DSS}$	-60	V
Gate-Source Voltage		$V_{GSS}$	±20	V
Continuous Drain Current (Note 7) V <sub>GS</sub> = -10V	$T_C = +25$ °C $T_C = +70$ °C	Ι <sub>D</sub>	-7.3 -5.8	А
Maximum Body Diode Forward Current (Note 7)	Is	-1.8	Α	
Pulsed Drain Current (380µs Pulse, 1% Duty Cycle)	I <sub>DM</sub>	-24	Α	
Pulsed Source Current (380µs Pulse, 1% Duty Cycle)	I <sub>SM</sub>	-24	Α	
Avalanche Current (Note 7) L = 0.1mH	I <sub>AS</sub>	-19	Α	
Repetitive Avalanche Energy (Note 7) L = 0.1mH		E <sub>AS</sub>	18	mJ

## Thermal Characteristics (@T<sub>A</sub> = +25°C, unless otherwise specified.)

Characteristic	Symbol	Value	Unit	
Total Power Dissipation (Note 6)	T <sub>A</sub> = +25°C	Б	1.2	W
Total Fower Dissipation (Note 6)	T <sub>A</sub> = +70°C	P <sub>D</sub>	0.75	VV
Thermal Resistance, Junction to Ambient (Note 6)	Steady State	Ъ	105	°C/W
Thermal Resistance, Junction to Ambient (Note 6)	t<10s	$R_{\theta JA}$	60	°C/W
Total Power Dissipation (Note 7)	$T_A = +25$ °C	Pn	1.8	W
Total Power Dissipation (Note 7)	T <sub>A</sub> = +70°C	PD	1.1	VV
Thermal Resistance, Junction to Ambient (Note 7)	Steady State	$R_{\theta,JA}$	69	°C/W
Thermal Resistance, Junction to Ambient (Note 1)	t<10s	МөЈА	39	°C/W
Thermal Resistance, Junction to Case (Note 7)	$R_{ heta JC}$	15	°C/W	
Operating and Storage Temperature Range		T <sub>J</sub> , T <sub>STG</sub>	-55 to +150	°C

# **Electrical Characteristics** (@T<sub>A</sub> = +25°C, unless otherwise specified.)

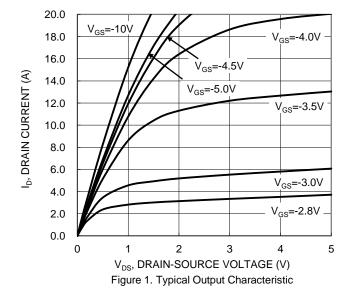
Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition	
OFF CHARACTERISTICS (Note 8)							
Drain-Source Breakdown Voltage	BV <sub>DSS</sub>	-60	_	_	V	$V_{GS} = 0V, I_D = -250\mu A$	
Zero Gate Voltage Drain Current	I <sub>DSS</sub>		_	-1	μΑ	$V_{DS} = -48V, V_{GS} = 0V$	
Gate-Source Leakage	I <sub>GSS</sub>	_	_	-100	nA	$V_{GS} = \pm 16V, V_{DS} = 0V$	
ON CHARACTERISTICS (Note 8)							
Gate Threshold Voltage	V <sub>GS(TH)</sub>	-1	_	-3	V	$V_{DS} = V_{GS}, I_{D} = -250 \mu A$	
Static Drain-Source On-Resistance		_	_	105	mΩ	$V_{GS} = -10V, I_D = -4.5A$	
Static Dialii-Source Off-Resistance	R <sub>DS(ON)</sub>	_	_	130	11177	$V_{GS} = -4.5V, I_D = -3.5A$	
Diode Forward Voltage	V <sub>SD</sub>	_	-0.7	-1.2	V	$V_{GS} = 0V, I_{S} = -1A$	
DYNAMIC CHARACTERISTICS (Note 9)							
Input Capacitance	CISS		969	_			
Output Capacitance	Coss		57	_	pF	$V_{DS} = -30V$ , $V_{GS} = 0V$ , $f = 1.0MHz$	
Reverse Transfer Capacitance	C <sub>RSS</sub>		44	_			
Gate Resistance	$R_{G}$		13.7	_	Ω	$V_{DS} = 0V, V_{GS} = 0V, f = 1.0MHz$	
Total Gate Charge (V <sub>GS</sub> = -4.5V)	$Q_G$		8.2	_			
Total Gate Charge (V <sub>GS</sub> = -10V)	$Q_G$		17.2	_	nC	V <sub>DS</sub> = -30V. I <sub>D</sub> = -12A	
Gate-Source Charge	$Q_{GS}$	_	3.0	_	IIC	V <sub>DS</sub> = -30V, I <sub>D</sub> = -12A	
Gate-Drain Charge	$Q_{GD}$	_	3.1	_			
Turn-On Delay Time	t <sub>D(ON)</sub>	_	4.4	_			
Turn-On Rise Time	t <sub>R</sub>	_	23	_	ns	$V_{GS} = -10V$ , $V_{DS} = -30V$ , $R_{GEN} = 3\Omega$ ,	
Turn-Off Delay Time	t <sub>D(OFF)</sub>	_	34	_	115	I <sub>D</sub> = -12A	
Turn-Off Fall Time	t <sub>F</sub>		42				
Body Diode Reverse Recovery Time	t <sub>RR</sub>	_	13.2	_	ns	1 100 11/14 1000///-	
Body Diode Reverse Recovery Charge	Q <sub>RR</sub>	1	6.18		nC	$I_S = -12A$ , $dI/dt = 100A/\mu s$	

Notes: 6. Device mounted on FR-4 substrate PC board, 2oz copper, with minimum recommended pad layout.

7. Device mounted on FR-4 substrate PC board, 2oz copper, with 1-inch square copper plate. 8. Short duration pulse test used to minimize self-heating effect.

9. Guaranteed by design. Not subject to product testing.





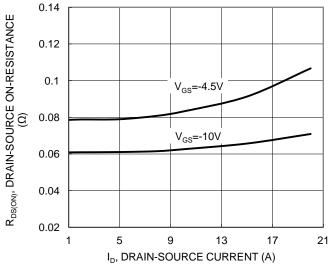


Figure 3. Typical On-Resistance vs. Drain Current and

Gate Voltage

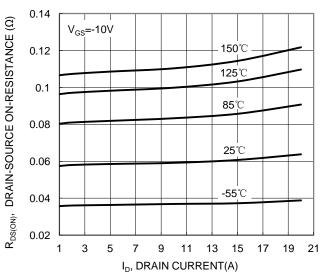
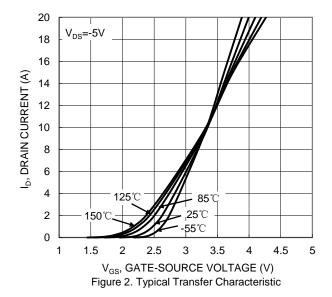
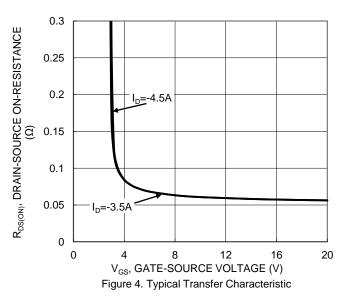


Figure 5. Typical On-Resistance vs. Drain Current and Temperature





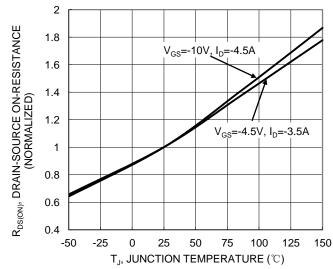


Figure 6. On-Resistance Variation with Temperature



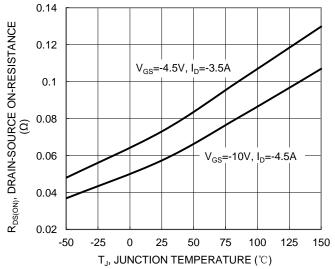


Figure 7. On-Resistance Variation with Temperature

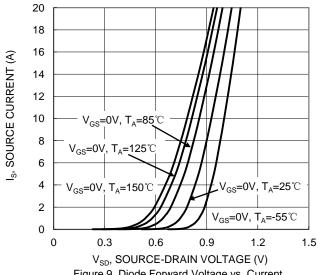
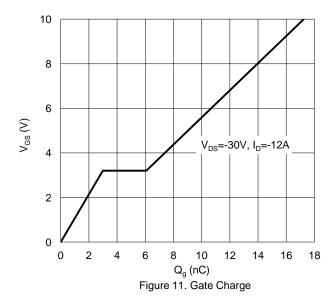
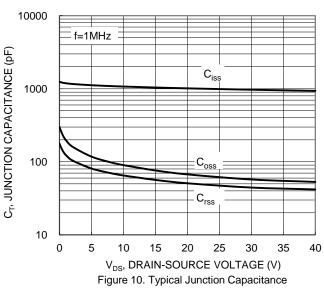


Figure 9. Diode Forward Voltage vs. Current



2.2  $V_{\text{GS(TH)}},$  GATE THRESHOLD VOLTAGE (V) 2 1.8  $I_D = -1mA$ 1.6  $I_{D} = -250 \mu A$ 1.4 1.2 1 0.8 -50 -25 25 50 75 100 125 150 T<sub>1</sub>, JUNCTION TEMPERATURE (°C)

Figure 8. Gate Threshold Variation vs. Junction Temperature



100  $R_{DS(ON)}$  Limited ID, DRAIN CURRENT (A) 10 1 P<sub>W</sub>=100ms  $T_{J(MAX)}$ =150°C 0.1 T<sub>A</sub>=25°C Single Pulse DUT on 1\*MRP board V<sub>GS</sub>= -10V 0.01 0.1 10 100  $V_{DS}$ , DRAIN-SOURCE VOLTAGE (V) Figure 12. SOA, Safe Operation Area



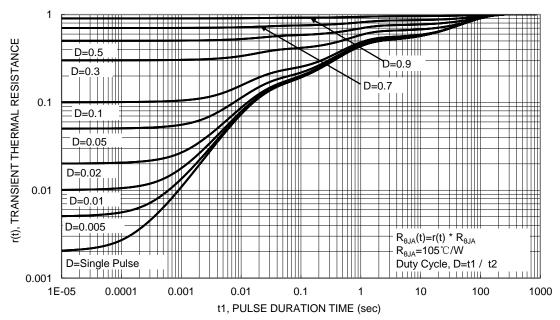


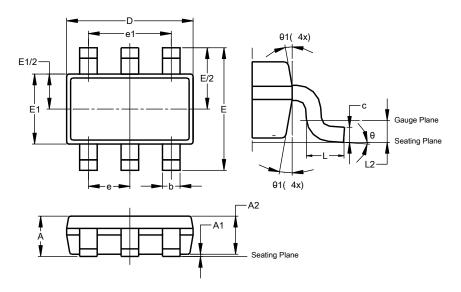
Figure 13. Transient Thermal Resistance



# **Package Outline Dimensions**

Please see http://www.diodes.com/package-outlines.html for the latest version.

#### TSOT26

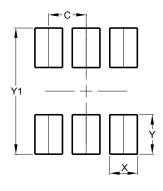


	TSOT26								
Dim	Min	Max	Тур						
Α	-	1.00	-						
A1	0.010	0.100	-						
A2	0.840	0.900	_						
۵	2.800	3.000	2.900						
Е	2.800 BSC								
E1	1.500	1.700	1.600						
b	0.300	0.450	-						
С	0.120	0.200	-						
е	0.950 BSC								
e1	1	.900 BS	С						
L	0.30	0.50	_						
L2	0.250 BSC								
θ	0°	8°	4°						
θ1	4°	12°	-						
Δ	All Dimensions in mm								

# **Suggested Pad Layout**

Please see http://www.diodes.com/package-outlines.html for the latest version.

### TSOT26



Dimensions	Value (in mm)
С	0.950
Х	0.700
Y	1.000
Y1	3 199



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